### **STL16N60M2**



# N-channel 600 V, 0.290 Ω typ., 8 A MDmesh™ M2 Power MOSFET in a PowerFLAT™ 5x6 HV package

Datasheet - production data

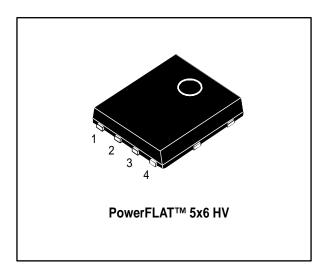
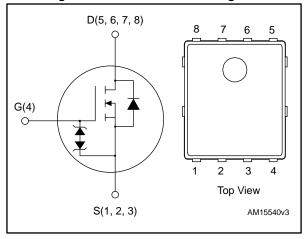


Figure 1: Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub> @ T <sub>Jmax</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	
STL16N60M2	650 V	0.355 Ω	8 A	

- Extremely low gate charge
- Excellent output capacitance (C<sub>OSS</sub>) profile
- 100% avalanche tested
- Zener-protected

### **Applications**

Switching applications

### **Description**

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

**Table 1: Device summary** 

Order code	Marking	Package	Packing	
STL16N60M2	16N60M2	PowerFLAT™ 5x6 HV	Tape and reel	

Contents STL16N60M2

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STL16N60M2 Electrical ratings

### 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>GS</sub>	Gate-source voltage	± 25	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	8 <sup>(1)</sup>	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	5	Α
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	32	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	52	W
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	15	V/ns
dv/dt <sup>(4)</sup>	MOSFET dv/dt ruggedness	50	V/ns
T <sub>stg</sub>	Storage temperature	- 55 to 150	°C
T <sub>j</sub>	Max. operating junction temperature	150	

#### Notes:

Table 3: Thermal data

Symbol	Symbol Parameter		Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	2.40	°C/W
R <sub>thj-pcb</sub>	Thermal resistance junction-pcb max <sup>(1)</sup>	59	°C/W

#### Notes:

**Table 4: Avalanche characteristics** 

Symbol Parameter		Value	Unit
I <sub>AR</sub>	Avalanche current, repetetive or not repetetive (pulse width limited by T <sub>jmax</sub> )	2	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>j</sub> = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 50 V)		mJ

<sup>&</sup>lt;sup>(1)</sup>The value is limited by package.

 $<sup>^{(2)}</sup>$ Pulse width limited by safe operating area.

 $<sup>^{(3)}</sup>I_{SD} \leq 8$  A, di/dt  $\leq 400$  A/µs; V<sub>DS peak</sub> < V<sub>(BR)DSS</sub>, V<sub>DD</sub> = 80% V<sub>(BR)DSS</sub>

 $<sup>^{(4)}</sup>V_{DS} \le 480 \text{ V}$ 

<sup>&</sup>lt;sup>(1)</sup>When mounted on 1 inch<sup>2</sup> FR-4, 2 Oz copper board

Electrical characteristics STL16N60M2

### 2 Electrical characteristics

(T<sub>C</sub>= 25 °C unless otherwise specified)

Table 5: On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	600			٧
	Zaro goto voltago Droin	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$			1	μΑ
I <sub>DSS</sub>	Zero gate voltage Drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V},$ $T_{C} = 125 \text{ °C}$			100	μΑ
I <sub>GSS</sub>	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4 A		0.290	0.355	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		1	704	ı	pF
Coss	Output capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz,	1	38	ı	pF
C <sub>rss</sub>	Reverse transfer capacitance	$V_{GS} = 0 V$	-	1.2	-	pF
Coss eq. (1)	Equivalent output capacitance	$V_{DS} = 0 \text{ V to } 480 \text{ V},$ $V_{GS} = 0 \text{ V}$	-	140	-	pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz open drain	-	5.3	-	Ω
$Q_g$	Total gate charge	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 12 A,	1	19	ı	nC
$Q_{gs}$	Gate-source charge	V <sub>GS</sub> = 10 V (see <i>Figure 15</i> :	- 1	3.3	•	nC
$Q_{gd}$	Gate-drain charge	"Gate charge test circuit")	-	9.5	-	nC

#### Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 6 \text{ A}$	-	10.5	-	ns
t <sub>r</sub>	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 V$ (see Figure 14: "Switching times	-	9.5	-	ns
t <sub>d(off)</sub>	Turn-off-delay time	test circuit for resistive load"	-	58	-	ns
t <sub>f</sub>	Fall time	and Figure 19: "Switching time waveform")	-	18.5	-	ns

 $<sup>^{(1)}</sup>C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

Table 8: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		8	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		32	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 8 A	1		1.6	V
t <sub>rr</sub>	Reverse recovery time		-	316		ns
Q <sub>rr</sub>	Reverse recovery charge	I <sub>SD</sub> = 12 A, di/dt = 100 A/μs, V <sub>DD</sub> = 60 V (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	3.25		μC
I <sub>RRM</sub>	Reverse recovery current	load switching and diode recovery times )		20.5		А
t <sub>rr</sub>	Reverse recovery time		-	455		ns
Qrr	Reverse recovery charge	$I_{SD}$ = 12 A, di/dt = 100 A/µs, $V_{DD}$ = 60 V, $T_{j}$ = 150 °C (see Figure 16: "Test circuit for inductive load switching and diode		4.8		μC
I <sub>RRM</sub>	Reverse recovery current	recovery times")	-	21		Α

#### Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_{D} = 0 \text{ A}$	30	1	ı	V

<sup>&</sup>lt;sup>(1)</sup>Pulse width is limited by safe operating area

 $<sup>^{(2)}\</sup>text{Pulse}$  test: pulse duration = 300  $\mu\text{s},$  duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

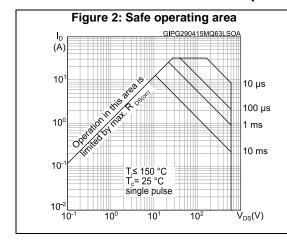


Figure 3: Thermal impedance

ZthPowerFlat  $5x6\_19$ 0.2

10<sup>-1</sup>

0.1

0.05

0.02

0.01

Zth = k RthJ-c  $\delta = t_p/\tau$ 10<sup>-3</sup>

10<sup>-6</sup>

10<sup>-5</sup>

10<sup>-4</sup>

10<sup>-3</sup>

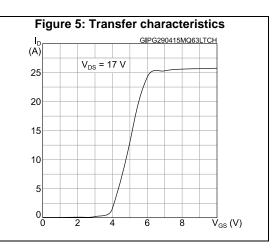
10<sup>-6</sup>

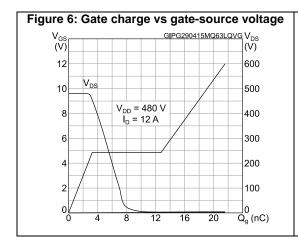
10<sup>-5</sup>

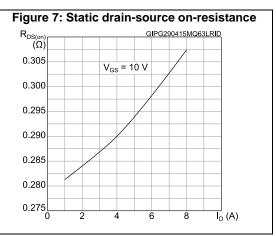
10<sup>-4</sup>

10<sup>-3</sup>

10<sup>-1</sup>







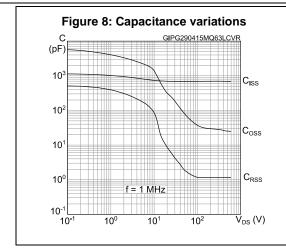


Figure 10: Normalized on-resistance vs temperature

R<sub>DS(on)</sub> GIPG290415MQ63LRON
(norm.)
2.2

1.8

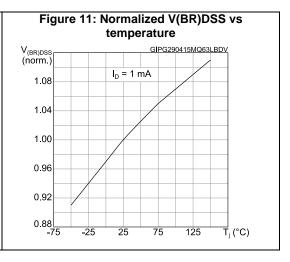
1.4

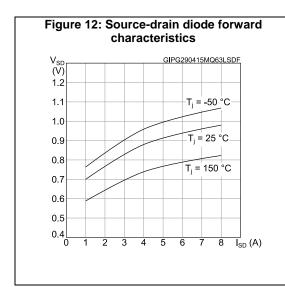
1.0

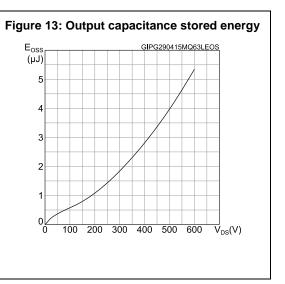
0.6

0.2

-75
-25
25
75
125
T<sub>j</sub> (°C)



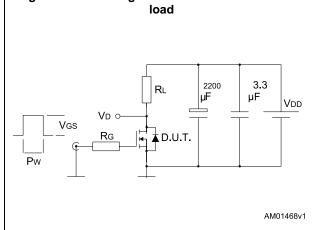




Test circuits STL16N60M2

### 3 Test circuits

Figure 14: Switching times test circuit for resistive



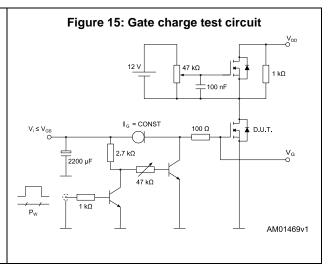


Figure 16: Test circuit for inductive load switching and diode recovery times

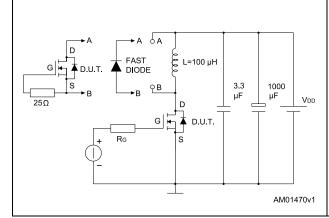
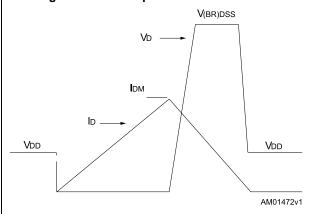
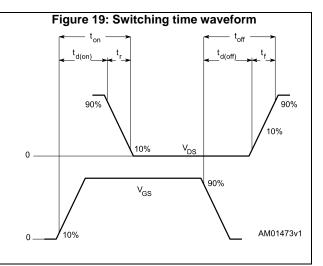


Figure 17: Unclamped inductive load test circuit

Figure 18: Unclamped inductive waveform





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# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



## 4.1 PowerFLAT™ 5x6 HV package information

Figure 20: PowerFLAT™ 5x6 HV package outline

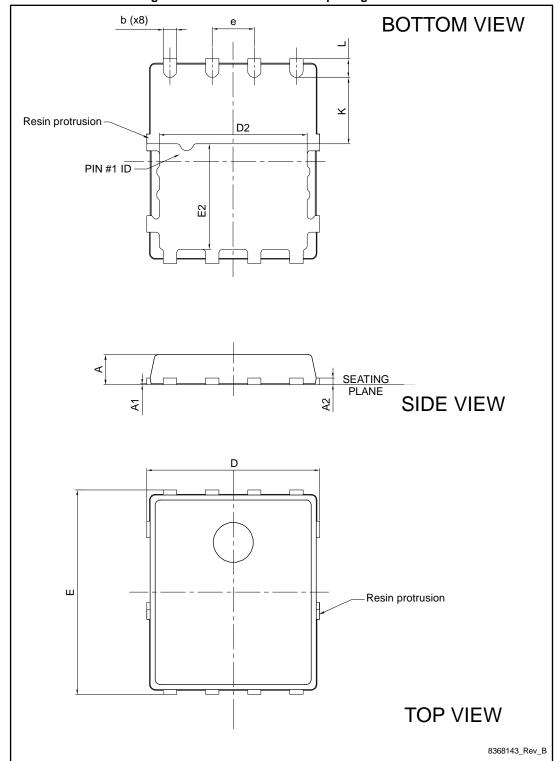
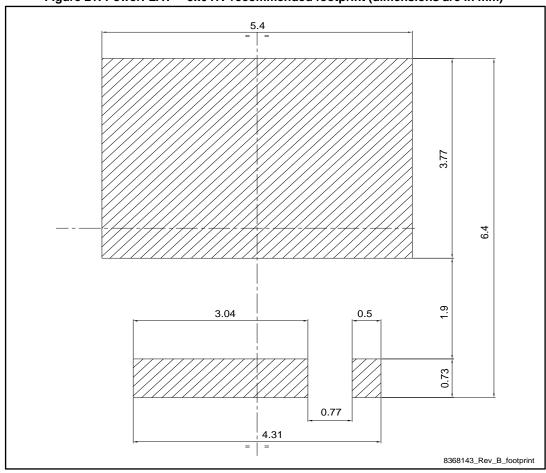


Table 10: PowerFLAT™ 5x6 HV mechanical data

Dim.		mm	
Dim.	Min.	Тур.	Max.
Α	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
D	5.00	5.20	5.40
Е	5.95	6.15	6.35
D2	4.30	4.40	4.50
E2	3.10	3.20	3.30
е		1.27	
L	0.50	0.55	0.60
K	1.90	2.00	2.10

Figure 21: PowerFLAT™ 5x6 HV recommended footprint (dimensions are in mm)



### 4.2 Packing information

Figure 22: PowerFLAT™ 5x6 tape (dimensions are in mm)

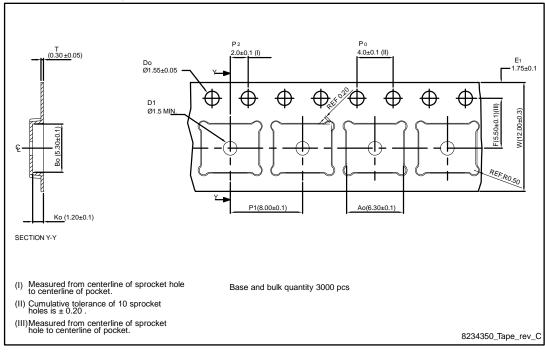
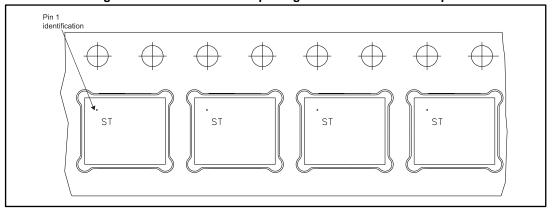


Figure 23: PowerFLAT™ 5x6 package orientation in carrier tape



8234350\_Reel\_rev\_C

Figure 24: PowerFLAT™ 5x6 reel W3 11.9/15.4 A 330 (+0/-4.0) ESD LOGO All dimensions are in millimeters

Revision history STL16N60M2

# 5 Revision history

**Table 11: Document revision history** 

Date	Revision	Changes
18-May-2015	1	First release.

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